

JMM4812N

Product Preview

30V N-Channel MOSFET

Features

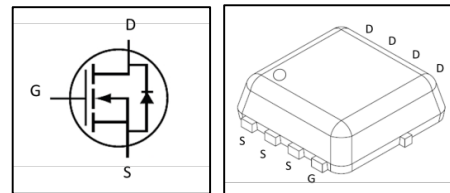
- Advanced shielded-gate technology
- Ultra-low on-resistance and gate-charge
- RoHS compliant
- 100% avalanche tested



Product Summary	
V_{DS}	30V
$R_{DS(ON)}$	4.1m Ω (Typ.)
	5.0m Ω (Max.)

Applications

- Motor controllers
- DC-to-DC convertors
- Battery-driven electronic products, electrical equipment and machines


Ordering Information

Part Number	Marking	Package	Packaging
JMM4812N	MM4812N	DFN5x6	Tape & Reel

Absolute Maximum Ratings

Parameter	Symbol	Limit	Unit
Drain-to-Source Voltage	V_{DS}	30	V
Gate-to-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_C = 25^\circ\text{C}$) ^{(1),(2)}	I_D	68	A
Continuous Drain Current ($T_C = 100^\circ\text{C}$) ^{(1),(2)}	I_D	43	
Continuous Drain Current ($T_A = 25^\circ\text{C}$) ^{(3),(4)}	I_D	16	
Continuous Drain Current ($T_A = 100^\circ\text{C}$) ^{(3),(4)}	I_D	10	
Pulsed Drain Current ⁽⁵⁾	I_{DM}	120	
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	37	W
Linear Derating Factor	-	0.29	W/°C
Single Pulse Avalanche Energy ⁽⁶⁾	E_{AS}	29	mJ
Avalanche Current ⁽⁷⁾	I_{AS}	17	A
Junction Temperature	T_J	-55 to 150	°C
Storage Temperature	T_{STG}	-55 to 150	

Thermal Characteristics

Parameter	Symbol	Max	Unit
Junction-to-Ambient Thermal Resistance ⁽⁴⁾	$R_{\theta JA}$	62	°C/W
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	3.4	

Static Electrical Characteristics⁽⁸⁾

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	30	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.1	-	2.2	
Drain-to-Source Leakage Current	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1	μA
		$V_{DS} = 24V, V_{GS} = 0V,$ $T_J = 125^\circ\text{C}$	-	-	10	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	± 100	nA
Drain-to-Source On-Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 20A$	-	4.1	5.0	m Ω
		$V_{GS} = 4.5V, I_D = 20A$	-	6.5	8.0	m Ω

Dynamic Electrical Characteristics ⁽⁸⁾

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Forward Transconductance	g_{fs}	$V_{DS} = 5V, I_D = 20A$	-	85	-	S
Total Gate Charge	Q_g	$V_{GS} = 10V,$ $V_{DS} = 15V,$ $I_D = 20A$	-	17.4	-	nC
Gate-to-Source Charge	Q_{gs}		-	3.4	-	
Gate-to-Drain Charge	Q_{gd}		-	3.1	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DS} = 15V,$ $I_D = 15A,$ $R_G = 3.0\Omega$	-	7	-	ns
Rise Time	t_r		-	2.8	-	
Turn-Off Delay Time	$t_{d(off)}$		-	21.4	-	
Fall Time	t_f		-	5.3	-	
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0V,$ $f = 1MHz$	-	960	-	pF
Output Capacitance	C_{oss}		-	410	-	
Reverse Transfer Capacitance	C_{rss}		-	60	-	

Diode Characteristics ⁽⁸⁾

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Forward Voltage	V_{SD}	$V_{GS} = 0V, I_S = 10A$	-	0.8	-	V
Reverse Recovery Time	T_{rr}	$V_{GS} = 0V, I_S = 20A,$ $di_S/dt = 100A/\mu s$	-	12.3	-	ns
Reverse Recovery Charge	Q_{rr}		-	17.6	-	nC

(1) Limited by package.

(2) Rated according to $R_{\theta JC}$.

(3) Rated according to $R_{\theta JA}$.

(4) Surface-mounted on 1 inch² FR4 board, 2 oz Cu.

(5) Limited by maximum T_J .

(6) Starting $T_J = 25^\circ C, I_{AS} = 17A, L = 0.1mH, V_{DD} = 20V, V_{GS} = 10V$

(7) Pulse width limited by maximum T_J .

(8) $T_J = 25^\circ C$ unless otherwise specified.

Typical Electrical Characteristics

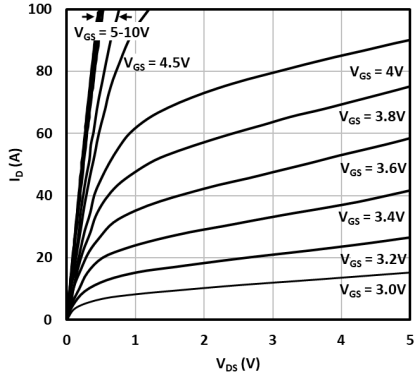


Fig. 1 Output characteristics

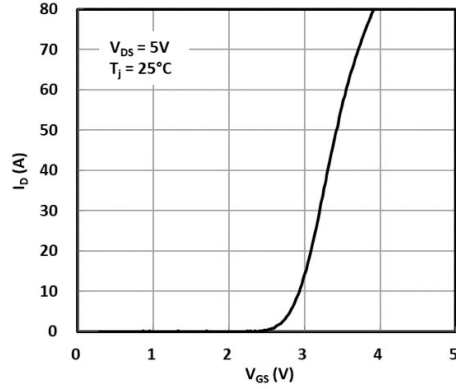


Fig. 2 Transfer characteristics

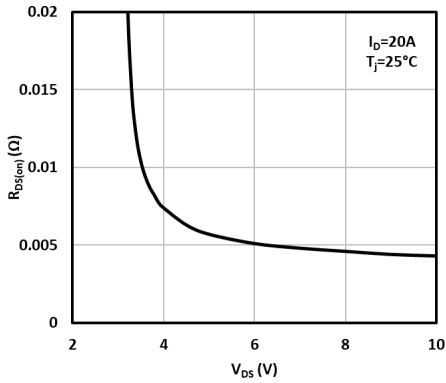


Fig.3 On-resistance vs. gate voltage

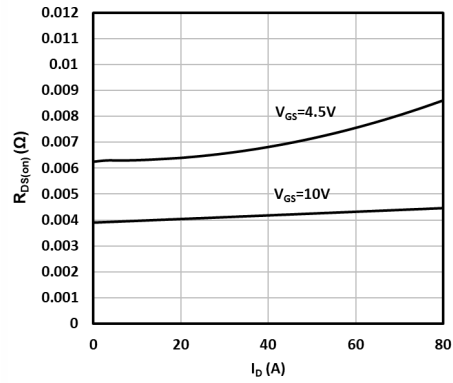


Fig.4 On-resistance vs. drain current

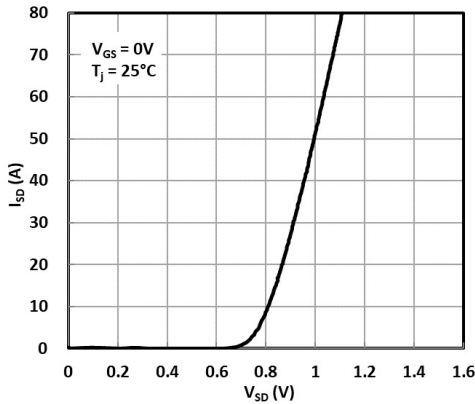


Fig.9 Source-to-drain diode forward characteristics

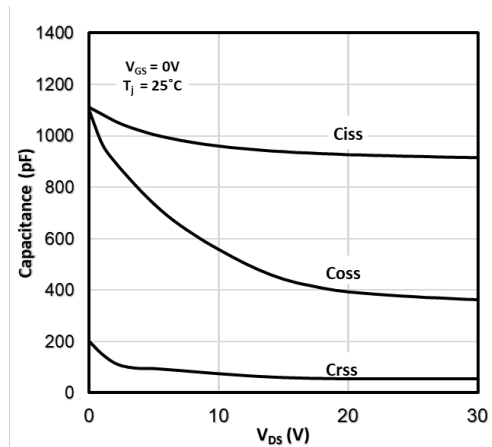


Fig.10 Capacitance vs. drain-to-source voltage

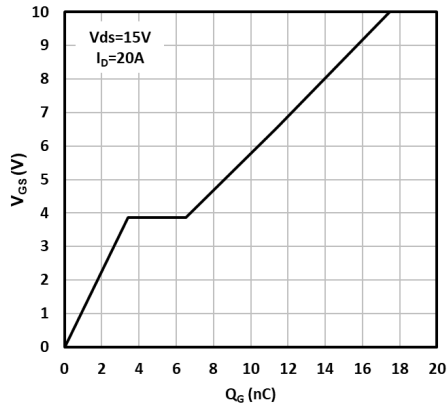


Fig.11 Gate-to-source voltage vs. gate charge

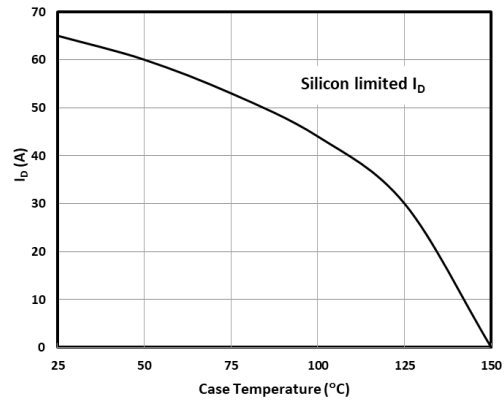


Fig.14 Maximum drain current vs. case temperature

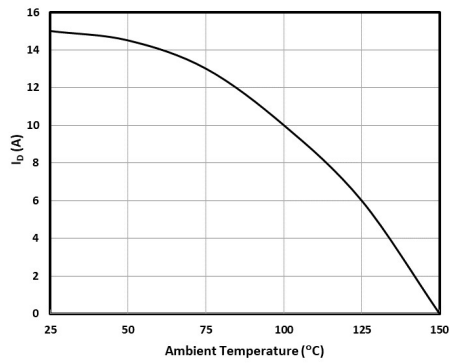
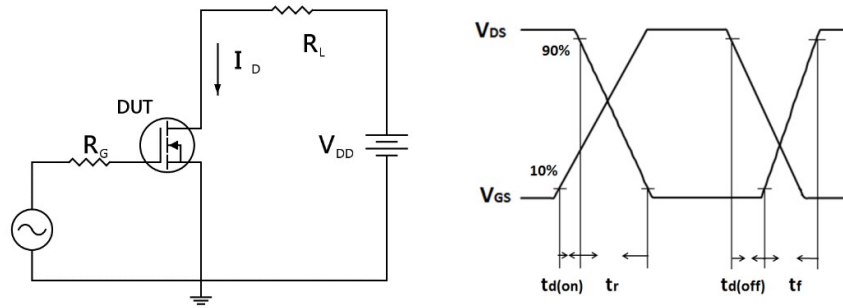
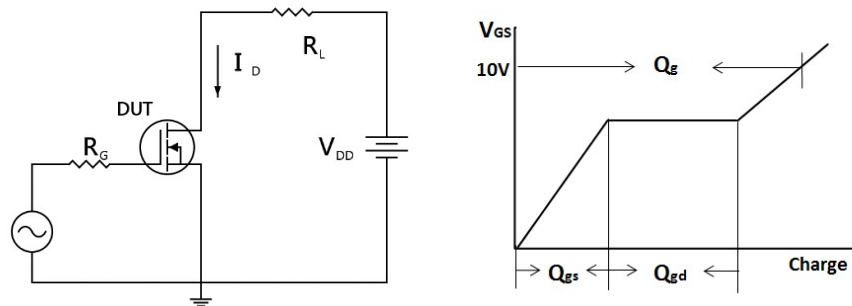


Fig.15 Maximum drain current vs. ambient temperature

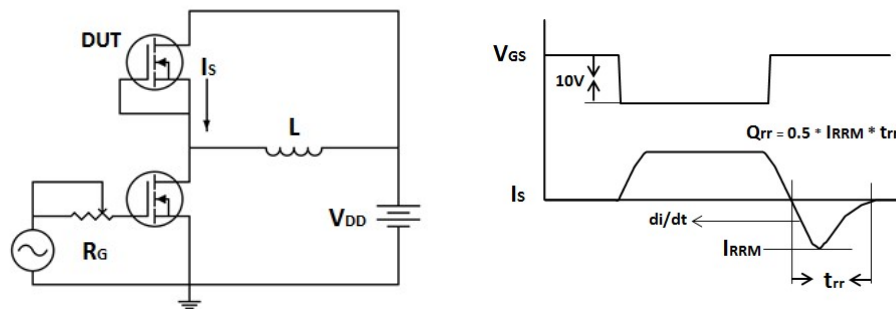
Test Circuits and Waveforms



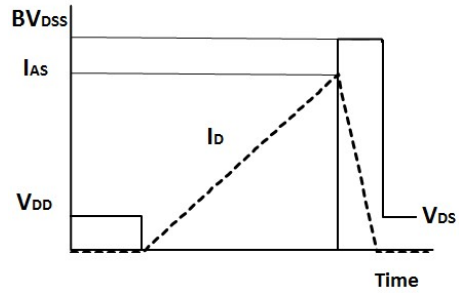
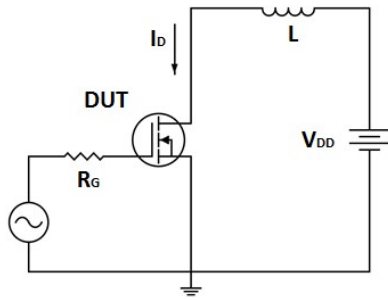
Resistive switching time test circuit & waveforms



Gate charge test circuit & waveform

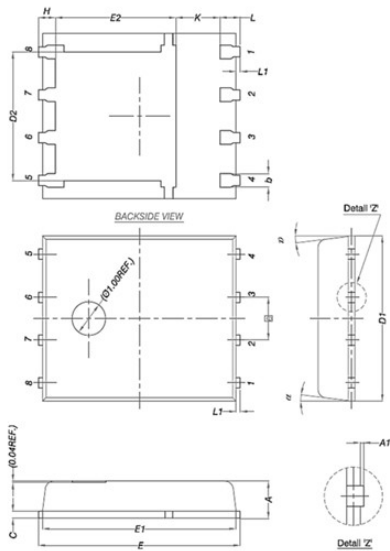


Peak diode recovery dv/dt test circuit & waveforms



Unclamped inductive switching test circuit & waveforms

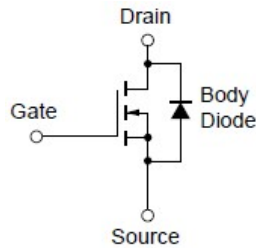
Package Drawing



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
α	0°	-	12°

DFN 5x6

Equivalent Circuit



Revision history of JMM4812N Specification

Version	Change Items	Effective Date
1.00	Initial Release	29-Oct-20

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